74F656A Octal buffer/driver with parity; non-inverting; 3-state Rev. 6 — 14 December 2011 Product data sheet

1. General description

The 74F656A is an octal buffer and line driver with parity generation/checking. The 74F656A can be used as memory address driver, clock driver and bus-oriented transmitter/receiver. The inclusion of parity generation/checking improves PCB density.

2. Features and benefits

- Combines 74F244 and 74F280A functions in one device
- High impedance NPN base inputs for reduced input current (40 µA in HIGH and LOW states)
- I_{IL} = 20 μ A compared to 600 μ A in FAST family specification
- For applications with high output drive and light bus loading
- Non-inverting
- 3-state output sink capability I_{OL} = 64 mA and source I_{OH} = 15 mA
- Inputs and outputs on separate sides simplifies board layout
- Combined functions reduce part count and enhance system performance
- Industrial temperature range available (-40 °C to +85 °C)

3. Ordering information

Table 1.Ordering information

Type number	Package			
	Temperature range	Name	Description	Version
N74F656AD	0 °C to 70 °C	SO24	plastic small outline package; 24 leads;	SOT137-1
I74F656AD	–40 °C to +85 °C		body width 7.5 mm	



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4. Functional diagram



Octal buffer/driver with parity; non-inverting; 3-state



5. Pinning information

5.1 Pinning



5.2 Pin description

Table 2.Pin description

Symbol	Pin	Description	Unit load HIGH/LOW	Load value ^[1] HIGH/LOW
OE0	1	output enable input (active LOW)	1.0/0.033	20 μΑ/20 μΑ
OE1	2	output enable input (active LOW)	1.0/0.033	20 μΑ/20 μΑ
PI	3	parity input	1.0/0.033	20 μΑ/20 μΑ
D0 to D7	4, 5, 6, 7, 8, 9, 10, 11	data input	2.0/0.066	40 μΑ/40 μΑ
GND	12	ground (0 V)		
Q0 to Q7	20, 19, 18, 17, 16, 15, 14, 13	data output	750/106.7	15 mA/64 mA
ΣΕ	21	even parity output	750/106.7	15 mA/64 mA
ΣΟ	22	odd parity output	750/106.7	15 mA/64 mA
OE2	23	output enable input (active LOW)	1.0/0.033	20 μΑ/20 μΑ
V _{CC}	24	supply voltage		

[1] One FAST Unit Load (UL) is defined as 20 μA in HIGH state, 0.6 μA in LOW state.

6. Functional description

Table 3. Function selection ^[1]							
Input				Output	Status		
OE0	OE1	OE2	Dn	Qn			
L	L	L	L	L	transparent		
L	L	L	Н	Н			
Н	Х	Х	Х	Z	disabled		
Х	Н	Х	Х	Z			
Х	Х	Н	Х	Z			

6.1 Function table

[1] H = HIGH voltage level;

L = LOW voltage level;

X = don't care;

Z = high-impedance OFF-state.

Table 4. Function parity outputs^[1]

Inputs	State	Parity output				
		ΣΕ	ΣΟ			
Even number of inputs (0, 2, 4, 6, 8)	Н	Н	L			
Odd number of inputs (1, 3, 5, 7, 9)	Н	L	Н			
Any OEn	Н	Z	Z			

[1] H = HIGH voltage level;

L = LOW voltage level;

Z = high-impedance OFF-state.

7. Limiting values

Table 5. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions	Min	Max	Unit
V _{CC}	supply voltage		-0.5	+7.0	V
VI	input voltage		<u>[1]</u> –0.5	+7.0	V
Vo	output voltage	output in HIGH-state	<u>[1]</u> –0.5	V _{CC}	V
I _{IK}	input clamping current	V ₁ < 0 V	-30	+5	mA
lo	output current	output in LOW-state	-	128	mA
T _{amb}	ambient temperature	in free-air	[2]		
		commercial	0	70	°C
		industrial	-40	+85	°C
T _{stg}	storage temperature		-65	+150	°C

[1] The input and output voltage ratings may be exceeded if the input and output current ratings are observed.

[2] The performance capability of a high-performance integrated circuit in conjunction with its thermal environment can create junction temperatures which are detrimental to reliability. The maximum junction temperature of this integrated circuit should not exceed 150 °C.

8. Recommended operating conditions

Table 6. Recommended operating conditions

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
V _{CC}	supply voltage		4.5	5.0	5.5	V
V _{IH}	HIGH-level input voltage		2.0	-	-	V
V _{IL}	LOW-level input voltage		-	-	0.8	V
I _{IK}	input clamping current		-	-	-18	mA
I _{OH}	HIGH-level output current		–15	-	-	mA
I _{OL}	LOW-level output current		-	-	64	mA

9. Static characteristics

Table 7. Static characteristics

Symbol	Parameter	Conditions	25 °C				–40 °C to +85 °C		
				Typ <mark>[1]</mark>	Max	Min	Max		
V _{IK}	input clamping voltage	$V_{CC} = 4.5 \text{ V}; \text{ I}_{IK} = -18 \text{ mA}$	-1.2	-0.73	-	-1.2	-	V	
V _{OH} HIGH-level output voltage	HIGH-level output	V_{CC} = 4.5 V; V_{IL} = 0.8 V; V_{IH} = 2.0 V							
	voltage	$I_{OH} = -3 \text{ mA}$							
		V _{CC} = ±10 %	-	-	-	2.4	-	V	
		$V_{CC} = \pm 5 \%$	-	3.3	-	2.7	-	V	
		I _{OH} = -15 mA							
		V _{CC} = ±10 %	-	-	-	2.0	-	V	

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Symbol	Parameter	Conditions			25 °C		–40 °C to +85 °C		Unit
				Min	Typ <mark>[1]</mark>	Max	Min	Max	
V _{OL}	LOW-level output	$V_{CC} = 4.5 \text{ V}; \text{ V}_{IL} = 0.8 \text{ V}; \text{ V}_{IH} = 2.0 \text{ V}$			1				
	voltage	I _{OL} = 64 mA							
		V _{CC} = ±10 %		-	-	-	-	0.55	V
		$V_{CC} = \pm 5 \%$		-	0.42	-	-	0.55	V
I _I	input leakage current	$V_{CC} = 0 V; V_{I} = 7.0 V$		-	-	-	-	100	μΑ
I _{IH}	HIGH-level input current	V_{CC} = 5.5 V; V_{I} = 2.7 V; commercial							
		pin Dn		-	-	-	-	40	μΑ
		pin PI, OEn		-	-	-	-	20	μΑ
		$V_{CC} = 5.5 \text{ V}; \text{ V}_{I} = 2.7 \text{ V}; \text{ industrial}$							
		pin Dn		-	-	-	-	80	μΑ
		pin PI, OEn		-	-	-	-	40	μΑ
IIL	LOW-level input current	$V_{CC} = 5.5 \text{ V}; \text{ V}_{I} = 0.5 \text{ V}$							
		pin Dn		-	-	-	-	-40	μΑ
		pin PI, OEn		-	-	-	-	-20	μΑ
l _{oz}	OFF-state output current	$V_{CC} = 5.5 V$							
		$V_0 = 2.7 V$		-	-	-	-	50	μΑ
		$V_{O} = 0.5 V$		-	-	-	-	-50	μΑ
lo	output current	V _{CC} = 5.5 V	[2]	-	-	-	-100	-225	mA
I _{CC}	supply current	V_{CC} = 5.5 V; V_{I} = GND or V_{CC}							
		outputs HIGH-state		-	50	-	-	80	mA
		outputs LOW-state		-	78	-	-	110	mA
		outputs OFF-state		-	83	-	-	90	mA

Table 7. Static characteristics ... continued

[1] All typical values are measured at $V_{CC} = 5$ V.

[2] Not more than one output should be tested at a time, and the duration of the test should not exceed one second.

10. Dynamic characteristics

Table 8. **Dynamic characteristics**

GND = 0 V; for test circuit, see <u>Figure 7</u>.

Symbol	Parameter	Conditions	25 °C; V _{CC} = 5.0 V			0 °C to 70 °C; V _{CC} = 5.0 V ± 0.5 V		-40 °C to +85 °C; V _{CC} = 5.0 V ± 0.5 V		Unit
			Min	Тур	Max	Min	Max	Min	Max]
t _{PLH} LOW to HIGH propagation delay	Dn to Qn; see <u>Figure 5</u>	2.0	4.0	6.5	2.0	7.0	2.0	8.0	ns	
		Dn to ΣE , ΣO ; see Figure 5	5.5	10.0	13.0	5.5	14.0	4.5	16.5	ns
t _{PHL} HIGH to LOW propagation delay	Dn to Qn; see <u>Figure 5</u>	2.5	5.5	7.0	2.5	7.5	2.5	9.0	ns	
		Dn to ΣE , ΣO ; see Figure 5	5.5	11.0	14.5	5.5	16.5	5.5	18.0	ns
t _{PZH}	OFF-state to HIGH propagation delay	OEn to Qn; see <u>Figure 6</u>	3.5	7.0	10.5	3.5	11.5	3.0	13.0	ns
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Symbol	Parameter	Conditions	25 °C; V _{CC} = 5.0 V		0 °C to 70 °C; V _{CC} = 5.0 V ± 0.5 V		–40 °C to +85 °C; V _{CC} = 5.0 V ± 0.5 V		Unit	
			Min	Тур	Max	Min	Max	Min	Max	
t _{PZL}	OFF-state to LOW propagation delay	OEn to Qn; see <u>Figure 6</u>	4.0	8.0	11.0	4.5	12.0	4.0	13.5	ns
t _{PHZ}	HIGH to OFF-state propagation delay	OEn to Qn; see <u>Figure 6</u>	1.5	4.5	8.0	1.5	9.0	1.5	10.0	ns
t _{PLZ}	LOW to OFF-state propagation delay	OEn to Qn; see Figure 6	2.0	5.0	8.0	2.0	9.0	1.5	10.0	ns

Dynamic characteristics ... continued Table 8.

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11. Waveforms





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Table 9. Test data

Input			Load		V _{EXT}			
VI	f _l	t _W	t _r , t _f	CL	RL	t _{PHL} , t _{PLH}	t _{PZH} , t _{PHZ}	t _{PZL} , t _{PLZ}
3.0 V	1 MHz	500 ns	≤ 2.5 ns	50 pF	500 Ω	open	open	7.0 V

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12. Package outline



Fig 8. Package outline SOT137-1 (SO24)

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13. Abbreviations

Table 10. Abbreviations	
Acronym	Description
DUT	Device Under Test
ESD	ElectroStatic Discharge
HBM	Human Body Model
MM	Machine Model
PCB	Printed-Circuit Board

14. Revision history

Table 11. Revision history

Document ID	Release date	Data sheet status	Change notice	Supersedes
74F656A v.6	20111214	Product data sheet	-	74F656A v.5
Modifications:	 Legal pages updated. 			
74F656A v.5	20100325	Product data sheet	-	74F656A v.4
74F656A v.4	20100205	Product data sheet	-	74F656A v.3
74F656A v.3	20000630	Product specification	-	74F656A v.2
74F656A v.2	19910717	Product specification	-	-

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15.1 Data sheet status

Document status[1][2]	Product status ^[3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
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Date of release: 14 December 2011 Document identifier: 74F656A